TOSHIBA CMOS DIGITAL INTEGRATED CIRCUIT SILICON MONOLITHIC

# TC7SL04F, TC7SL04FU

#### **INVERTER**

The TC7SL04 is a low voltage operative C<sup>2</sup>MOS INVERTER fabricated with silicon gate C<sup>2</sup>MOS technology.

Operating voltage ( $V_{CC(opr)}$ ) is 1~3V equivalent to 1pc or 2pcs of dry cell battery and it achives low power dissipation.

The internal circuit is composed of 3 stages including buffer output, which enables high noise immunity and stable output.

The input is equipped with protection circuits against static discharge or transient excess voltage.

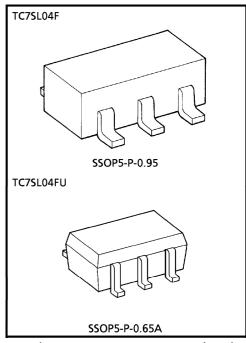
#### **FEATURES**

•	High Speed ······	$t_{pd} = 10ns (Typ.)$
		at $V_{CC} = 3V$

• Low Power Dissipation 
$$\cdots I_{CC} = 1\mu A$$
 (Max.) at  $Ta = 25^{\circ}C$ 

Balanced Propagation Delay Time ··· t<sub>pLH</sub>≒t<sub>pHL</sub>

• Low Voltage Operating············V<sub>CC</sub> (opr) = 1~3.6V

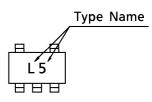


Weight SSOP5-P-0.95 : 0.016g (Typ.) SSOP5-P-0.65A : 0.006g (Typ.)

#### **MAXIMUM RATINGS**

CHARACTERISTIC	SYMBOL	RATING	UNIT
Supply Voltage Range	Vcc	-0.5~5	V
DC Input Voltage	VIN	-0.5~V <sub>CC</sub> +0.5	V
DC Output Voltage	VOUT	-0.5~V <sub>CC</sub> +0.5	V
Input Diode Current	ΙΚ	± 20	mA
Output Diode Current	loк	± 20	mA
DC Output Current	IOUT	± 12.5	mA
DC V <sub>CC</sub> / Ground Current	Icc	± 25	mA
Power Dissipation	PD	200	mW
Storage Temperature	T <sub>stg</sub>	<b>- 65∼150</b>	°C
Lead Temperature (10s)	TL	260	°C

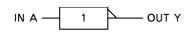
#### MARKING

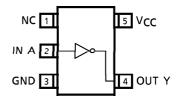


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#### LOGIC DIAGRAM

# PIN CONNECTION (TOP VIEW)





#### **RECOMMENDED OPERATING CONDITIONS**

CHARACTERISTIC	SYMBOL	RATING	UNIT		
Supply Voltage	V <sub>CC</sub>	1~3.6	V		
Input Voltage	V <sub>IN</sub>	0~V <sub>CC</sub>	V		
Output Voltage	Vout	0~V <sub>CC</sub>	V		
Operating Temperature	T <sub>opr</sub>	-40~85	°C		
		$0\sim 1000 (V_{CC} = 1.0V)$	ns		
Input Rise and Fall Time	t <sub>r</sub> , t <sub>f</sub>	0∼ 500 (VCC = 1.5V)			
		0~ 400 (V <sub>CC</sub> = 3.0V)			

#### DC ELECTRICAL CHARACTERISTICS

CHARACTERISTIC	SYMBOL	TEST CIR-	R- TEST CONDITION			Ta = 25°C			Ta = − 40~85°C		UNIT
CHARACTERISTIC	STIVIBOL	CUIT			$V_{CC}$	MIN.	TYP.	MAX.	MIN.	MAX.	UNIT
High-Level Input	VIH				1.0	0.75	_	_	0.75	-	
Voltage		—		_	1.5	1.05	_	_	1.05	—	V
					3.0	2.10		_	2.10		1
Low-Level Input					1.0	_	_	0.25	—	0.25	
Voltage	VIL	—		_	1.5	_	_	0.45	—	0.45	V
Voltage					3.0	_		0.90	<b>—</b>	0.90	
				I <sub>OH</sub> = -20μA	1.0	0.9	1.0	_	0.9	—	V
High Lavel	V <sub>OH</sub>		- V <sub>IN</sub> = V <sub>IL</sub>		1.5	1.4	1.5		1.4	—	
High-Level		—			3.0	2.9	3.0		2.9	—	
Output Voltage				I <sub>OH</sub> = - 1mA	1.5	1.07	1.23	_	0.99		
				$I_{OH} = -2.6 \text{mA}$	3.0	2.61	2.68	_	2.55	—	
	V <sub>OL</sub>		V <sub>IN</sub> = V <sub>IH</sub>	I <sub>OL</sub> = 20μA	1.0	_	0.0	0.1	_	0.1	$ \mid v \mid $
Laver Laver		_			1.5	_	0.0	0.1	—	0.1	
Low-Level					3.0	_	0.0	0.1	l —	0.1	
Output Voltage				I <sub>OL</sub> = 1mA	1.5	_	0.23	0.31	_	0.37	
				$I_{OL} = 2.6 mA$	3.0	_	0.23	0.31	<b> </b>	0.33	
Input Leakage	IN	_	V <sub>IN</sub> = V <sub>CC</sub>	or GND	3.6	_	_	±0.1	_	± 1.0	
Current			111 66								$\mu$ A
Quiescent Supply Current	lcc	_	V <sub>IN</sub> = V <sub>CC</sub>	or GND	3.6	_	_	1.0	_	10.0	<i>,</i>

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### AC ELECTRICAL CHARACTERISTICS ( $C_L = 15pF$ , Input $t_r = t_f = 6ns$ , $V_{CC} = 3.3 \pm 0.3 V$ )

CHARACTERISTIC	CAMBOI	TEST CIR- CUIT	TEST CONDITION	7	UNIT		
CHARACTERISTIC	3 TIVIBOL			MIN.	TYP.	MAX.	UIVII
Output Transition	tTLH				5.0	9.0	ns
Time	tTHL		_		3.0	3.0	113
Propagation	t <sub>PLH</sub>				7.5	13.0	ns
Delay Time	t <sub>PHL</sub>		<del>_</del>	_	/.5	13.0	113

## AC ELECTRICAL CHARACTERISTICS ( $C_L = 25pF$ , Input $t_r = t_f = 6ns$ )

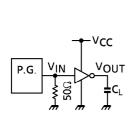
CHARACTERISTIC	SYMBOL	TEST	TEST CONDITION		Ta = 25°C			Ta = -4		
CHARACTERISTIC	3 TIVIBOL	CIR- CUIT	TEST CONDITION	VCC	MIN.	TYP.	MAX.	MIN.	MAX.	UNIT
Output Transition	t			1.0	_	70	170	_	240	
Time	t <sub>TLH</sub>	—	_	1.5	_	25	45	_	55	ns
Time	t <sub>THL</sub>			3.0	_	10	15		20	
Dropogotion	4			1.0	_	70	170	_	210	
Propagation	t <sub>PLH</sub>	_	<u> </u>	1.5	l —	25	45	<b> </b>	55	ns
Delay Time	t <sub>PHL</sub>			3.0	—	10	15	_	20	
Input Capacitance	CIN		_		_	5	10	_	10	
Power Dissipation Capacitance	C <sub>PD</sub>	_	Note (1)		_	10	_	_	_	pF

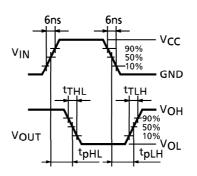
Note (1): C<sub>PD</sub> defined as the value of internal equivalent capacitance of IC which is calculated from the operating current consumption without load (refer to Test Circuit).

Average operating current can be obtained by the equation as follows.

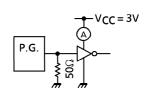
ICC (opr) = CPD·VCC·fIN + ICC

#### SWITCHING CHARACTERISTICS TEST CIRCUIT





ICC (opr) TEST CIRCUIT



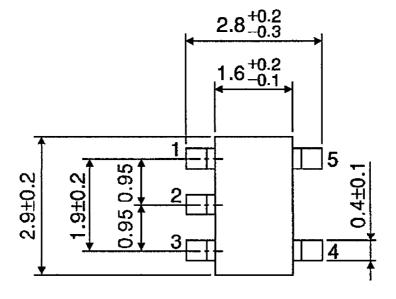
Input waveform is the same as that in case of switching characteristics test.

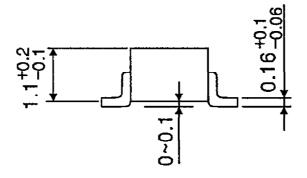
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# PACKAGE DIMENSIONS

SSOP5-P-0.95

Unit: mm

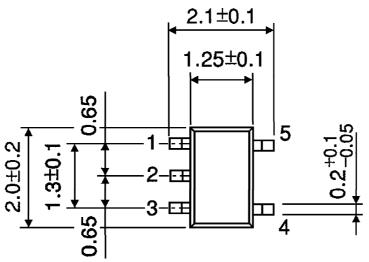




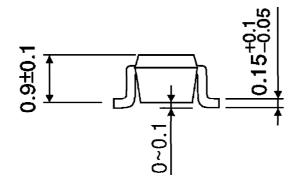
Weight: 0.016g (Typ.)

# PACKAGE DIMENSIONS

SSOP5-P-0.65A



Unit: mm



Weight: 0.006g (Typ.)

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